

<b>Notice of References Cited</b>	Application/Control No. 10/821,106	Applicant(s)/Patent Under Reexamination VIITAMAKI ET AL.	
	Examiner David Q. Nguyen	Art Unit 2617	Page 1 of 1

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*	B	US-2005/0013264	01-2005	Sundberg, Per-Erik	370/328
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